

Supporting Information

Self-powered, ultra-broadband, and polarization-sensitive photodetectors based on 1D van der Waals layered material

$\text{Nb}_2\text{Pd}_3\text{Se}_8$

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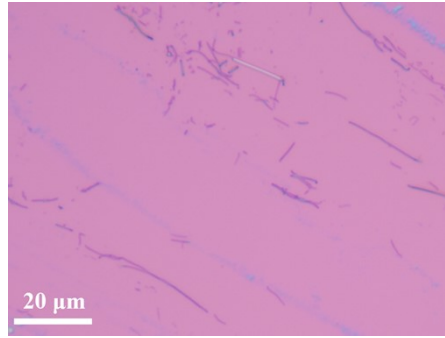


Figure S1. Optical image of the exfoliated Nb₂Pd₃Se₈ nanowires.

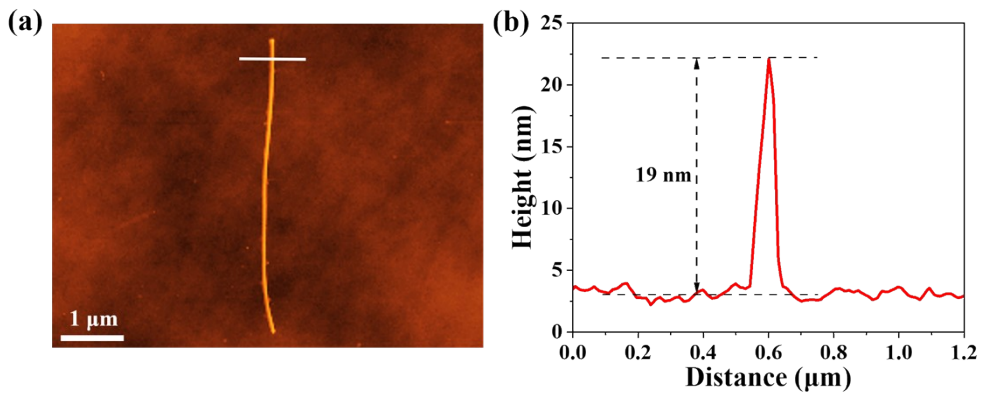


Figure S2. (a) AFM image of exfoliated Nb₂Pd₃Se₈ nanowire. b) Height profiles corresponding to the line in (a).

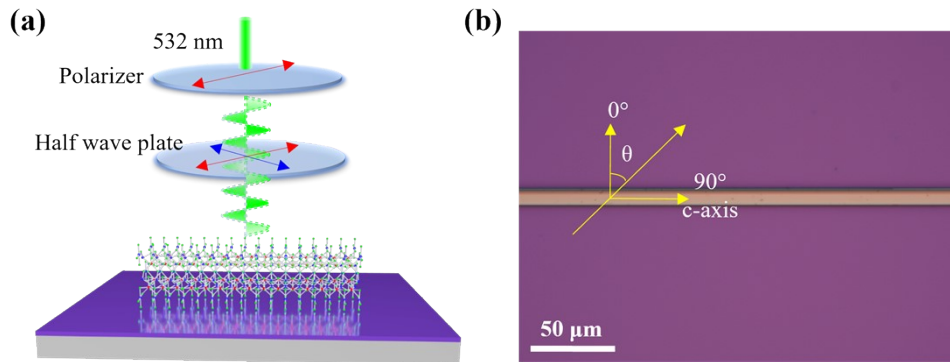


Figure S3. (a) Schematic diagram of the experimental setup for the polarized Raman test. (b) Optical image of the bulk Nb₂Pd₃Se₈.

From a semi-classical perspective, the Raman intensity of Nb₂Pd₃Se₈ can be identified by:

$$I \propto |e_i \cdot R \cdot e_s|^2 \quad S(1)$$

where e_i and e_s are the unit polarization vectors of incident and scattered lasers, respectively, and R is the Raman tensor. The unit polarization vector is $e_i = (\cos \theta, 0, \sin \theta)$, where θ is the angle between incident light polarization and a axis direction of the Nb₂Pd₃Se₈. And $e_s = (\cos \theta, 0, \sin \theta)$ and $e_s = (-\sin \theta, 0, \cos \theta)$ correspond to e_s in parallel and perpendicular configurations, respectively. For an absorptive material, the

Raman tensor elements are complex values, with real and imaginary parts.¹ Bulk $\text{Nb}_2\text{Pd}_3\text{Se}_8$ belongs to the Pbam space group. Thus, the Raman tensor can be expressed as

$$\begin{aligned} \mathbf{R}(A_g) &= \begin{pmatrix} |a|e^{i\varphi_a} & 0 & 0 \\ 0 & |b|e^{i\varphi_b} & 0 \\ 0 & 0 & |c|e^{i\varphi_c} \end{pmatrix} & \mathbf{R}(B_{1g}) &= \begin{pmatrix} 0 & |d|e^{i\varphi_d} & 0 \\ |d|e^{i\varphi_d} & 0 & 0 \\ 0 & 0 & 0 \end{pmatrix} \\ \mathbf{R}(B_{2g}) &= \begin{pmatrix} 0 & 0 & |e|e^{i\varphi_e} \\ 0 & 0 & 0 \\ |e|e^{i\varphi_e} & 0 & 0 \end{pmatrix} & \mathbf{R}(B_{3g}) &= \begin{pmatrix} 0 & 0 & 0 \\ 0 & 0 & |f|e^{i\varphi_f} \\ 0 & |f|e^{i\varphi_f} & 0 \end{pmatrix} \end{aligned} \quad \text{S(2)}$$

where φ_a , φ_b , φ_c , φ_d , φ_e , and φ_f are the corresponding phases of the Raman tensor elements.² Then, the Raman scattering intensities of different modes can further be expressed as

$$I(A_g, //) \propto |c|^2 \left\{ \left(\sin^2\theta + \frac{|a|^2}{|c|^2} \cos\varphi_{ca} \cos^2\theta \right)^2 + \left(\frac{|a|}{|c|} \sin\varphi_{ca} \cos^2\theta \right)^2 \right\} \quad \text{S(3)}$$

$$I(B_{2g}, //) \propto |e|^2 \sin^2 2\theta \quad \text{S(4)}$$

where $//$ represents parallel polarizations, and $\varphi_{ca} = \varphi_c - \varphi_a$ is the phase difference. It can be seen that the calculated curves fitted well with the experimental data in Figure 2f.

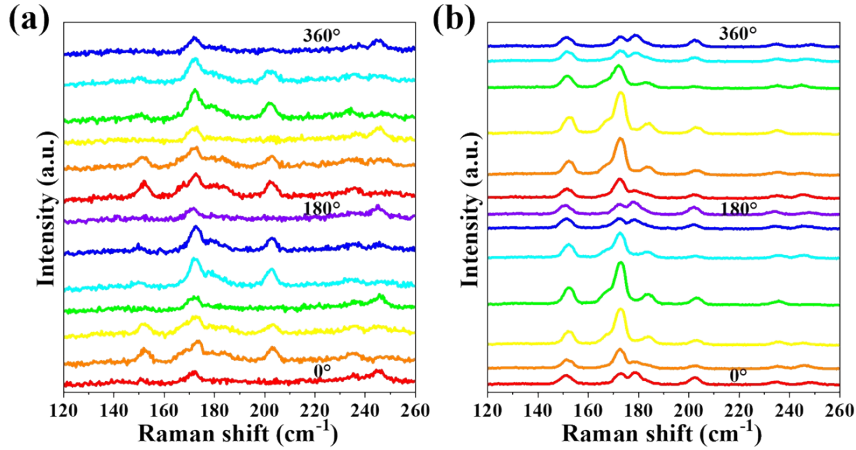


Figure S4. Angle-resolved polarized Raman spectra acquired in the (a) parallel configuration and (d) perpendicular configuration.

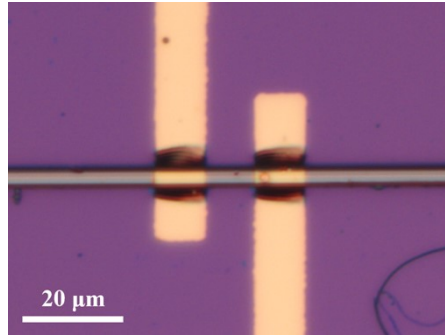


Figure S5. Optical image of the Nb₂Pd₃Se₈ device.

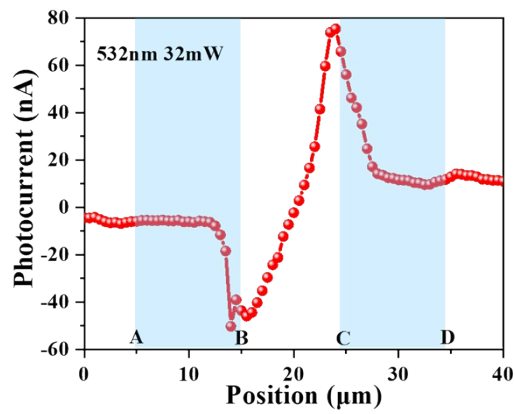


Figure S6. Photocurrent response of the Nb₂Pd₃Se₈ device along a line cut in Figure 4b. The blue portions represent the Au electrodes of the device.

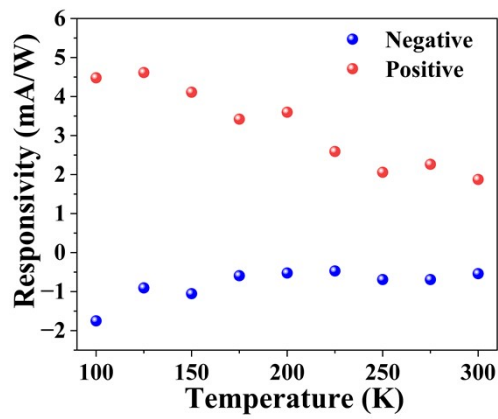


Figure S7. The responsivity of the Nb₂Pd₃Se₈ photodetector under different temperatures.

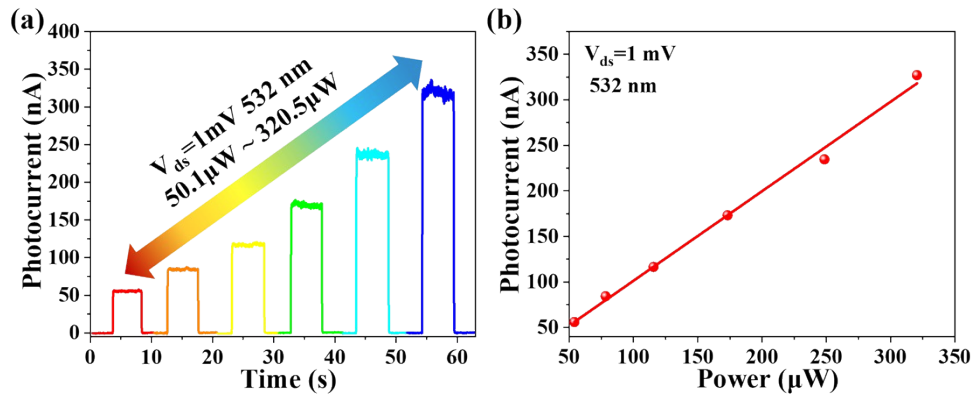


Figure S8. (a) Photoresponse of the $\text{Nb}_2\text{Pd}_3\text{Se}_8$ photodetector with a bias of 1 mA to different light intensities under 532 nm light illumination. (b) A good linear relationship between photoresponse and light intensities in the experimental range.

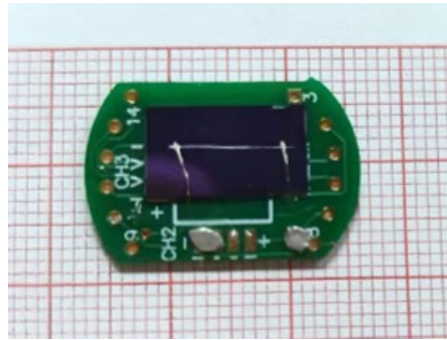


Figure S9. Optical image of the $\text{Nb}_2\text{Pd}_3\text{Se}_8$ device for broadband detection.

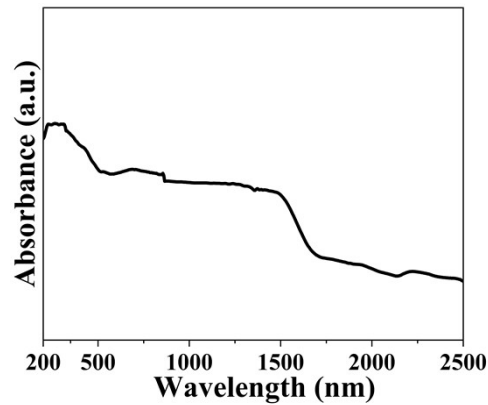


Figure S10. Absorption spectrum of the $\text{Nb}_2\text{Pd}_3\text{Se}_8$.

Table S1. Comparison of Photodetectors Reported in the Literature.

Materials	Responsivity	Response time	Polarization extinction ratio	Spectral Range (μm)	Ref.
PtTe ₂	0.04 mA W ⁻¹	34 μs	1.11 (633 nm)	0.532-4	3
NdSb ₂	0.49 mA W ⁻¹	15 μs	1.6 (532 nm)	0.532-4	4
MoTe ₂	0.4 mA W ⁻¹	43 μs	1.19 (633 nm)	0.532-10.6	5
TaIrTe ₄	0.02 mA W ⁻¹	27 μs	1.13 (633 nm)	0.532–10.6	6
Cd ₃ As ₂	5.9 mA W ⁻¹	6.9 ps	—	0.532-10.6	7
Nb ₂ Pd ₃ Se ₈	2.74 mA W ⁻¹	55 ms	1.42 (532 nm)	0.365-10.6	This work

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